



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	BV _{DSS}	R _{DS(ON)}	I _D T _A = +25°C
Q1 30V		$60m\Omega @ V_{GS} = 10V$	3.4A
Q1 30V	300	100mΩ @ V _{GS} = 4.5V	2.7A
Q2	-30V	95mΩ @ V _{GS} = -10V	-2.7A
Q2	-307	140mΩ @ V _{GS} = -4.5V	-2.2A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Backlighting
- DC-DC Converters
- Power Management Functions

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

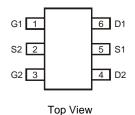
Mechanical Data

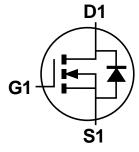
- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 ³
- Weight: 0.013 grams (Approximate)

TSOT26

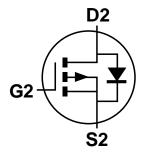


Top View





Q1 N-Channel MOSFET



Q2 P-Channel MOSFET

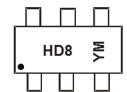
Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3061SVT-7	TSOT26	3000 / Tape & Reel
DMC3061SVT-13	TSOT26	10000 / Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



HD8 = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: G = 2019) M = Month (ex: 9 = September)

Date Code Key

	,														
ſ	Year	201	9	2020		2021		2021 2022		2022 2023			2024	2025	
	Code	G		Н		I		J	K		L	M			
Ī	Month	Jan	Feb	Mar	Apr	pr May		Jul	Aug	Sep	Oct	Nov	Dec		
	Code	1	2	3	4	5	6	7	8	9	0	N	D		



Maximum Ratings - Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristi	Symbol	Value	Unit		
Drain-Source Voltage	V _{DSS}	30	V		
Gate-Source Voltage	V_{GSS}	±20	V		
Continuous Drain Current (Note 6) V _{GS} = 4.5V	I _D	3.4 2.7	А		
Maximum Continuous Body Diode Forward Current (Is	1.4	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I _{DM}	20	Α

Maximum Ratings – Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristi	Symbol	Value	Unit		
Drain-Source Voltage	V_{DSS}	-30	V		
Gate-Source Voltage	V_{GSS}	±20	V		
Continuous Drain Current (Note 6) V _{GS} = -4.5V	I _D	-2.7 -2.2	А		
Maximum Continuous Body Diode Forward Current (Is	-1.3	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I _D	-15	Α

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P _D	0.88	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	R _{θJA}	142	°C/W
Power Dissipation (Note 6)	P _D	1.08	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 6)	R _{θJA}	116	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)				•	•	
Drain-Source Breakdown Voltage	BV_{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1.0	μΑ	$V_{DS} = 24V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(TH)}	0.5	1.3	1.8	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
			35	60		$V_{GS} = 10V, I_D = 3.1A$
Static Drain-Source On-Resistance	R _{DS(ON)}	_	41	100	mΩ	V _{GS} = 4.5V, I _D = 2A
	,		51	200		V _{GS} = 3.3V, I _D = 1.5A
Diode Forward Voltage	V_{SD}	_	0.7	1	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 8)					•	
Input Capacitance	Ciss	_	278	_		151/11/
Output Capacitance	Coss	_	44	_	pF	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	Crss		29	_		1 = 1.000112
Gate Resistance	R_{g}	_	4.2		Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	3.5	_		V _{DS} = 15V, V _{GS} = 4.5V, I _D = 3A
Total Gate Charge (V _{GS} = 10V)	Qg	_	6.6	_	~_	
Gate-Source Charge	Q _{qs}	_	0.1	_	nC	$V_{DS} = 15V, V_{GS} = 10V, I_{D} = 3A$
Gate-Drain Charge	Q _{gd}		1.3	_		
Turn-On Delay Time	t _{D(ON)}		5.7	_		
Turn-On Rise Time	t _R		97	_		$V_{GS} = 10V, V_{DS} = 15V,$
Turn-Off Delay Time	t _{D(OFF)}	_	12.6	_	ns	$R_G = 3\Omega$, $R_L = 1.7\Omega$
Turn-Off Fall Time	t _F	_	51	_		

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

^{7.} Short duration pulse test used to minimize self-heating effect.

^{8.} Guaranteed by design. Not subject to production testing.



Electrical Characteristics – Q2 (@T_A = +25°C, unless otherwise specified.)

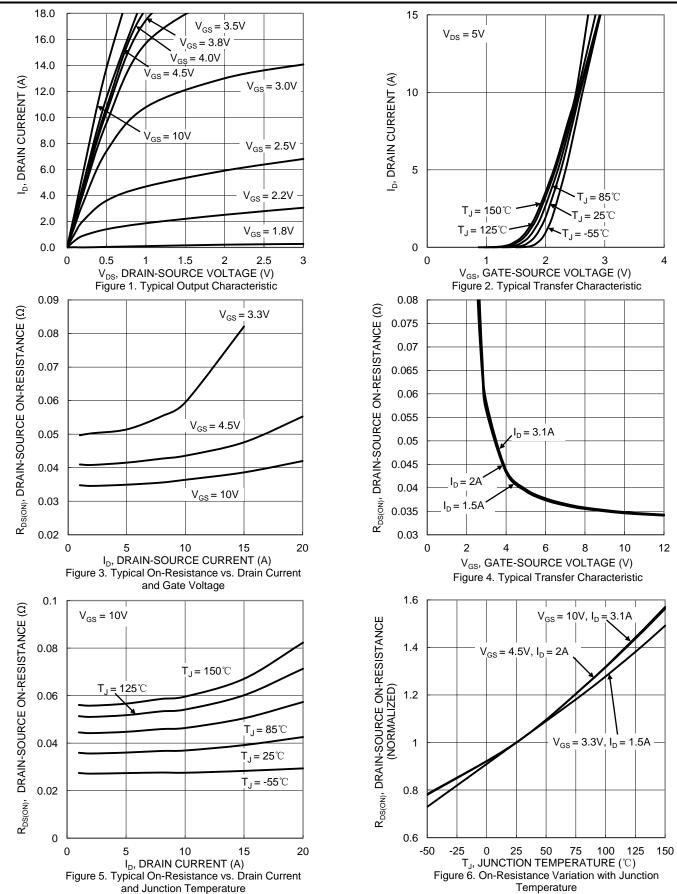
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV _{DSS}	-30	1	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}			-1.0	μΑ	$V_{DS} = -24V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(TH)}	-0.5	-1.5	-2.2	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
			65	95		$V_{GS} = -10V, I_D = -2.7A$
Static Drain-Source On-Resistance	R _{DS(ON)}	_	97	140	mΩ	$V_{GS} = -4.5V, I_D = -2A$
	= = (= : :)		145	200		$V_{GS} = -3.3V, I_D = -1.5A$
Diode Forward Voltage	V_{SD}	_	-0.8	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	_	287	_		
Output Capacitance	Coss		43	_	pF	$V_{DS} = -15V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	Crss	_	30	_		I = 1.0WII IZ
Gate Resistance	R_g	_	8.3	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = -4.5V)	Qg	_	3.5	_		$V_{DS} = -15V$, $V_{GS} = -4.5V$, $I_{D} = -3A$
Total Gate Charge (V _{GS} = -10V)	Q_g	_	6.8	_	nC	
Gate-Source Charge	Q_{gs}	_	0.4	_	nc nc	$V_{DS} = -15V$, $V_{GS} = -10V$, $I_{D} = -3A$
Gate-Drain Charge	Q_{gd}	_	1.1	_		
Turn-On Delay Time	t _{D(ON)}	_	7.4	_		
Turn-On Rise Time	t _R	_	17.9	_		$V_{GS} = -10V, V_{DS} = -15V,$
Turn-Off Delay Time	t _{D(OFF)}	_	19.6	_	ns	$R_G = 6\Omega$, $R_L = 15\Omega$
Turn-Off Fall Time	t _F	_	21.8	_		

Notes:

^{7.} Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to production testing.



Typical Characteristics - N-Channel





Typical Characteristics – N-Channel (continued)

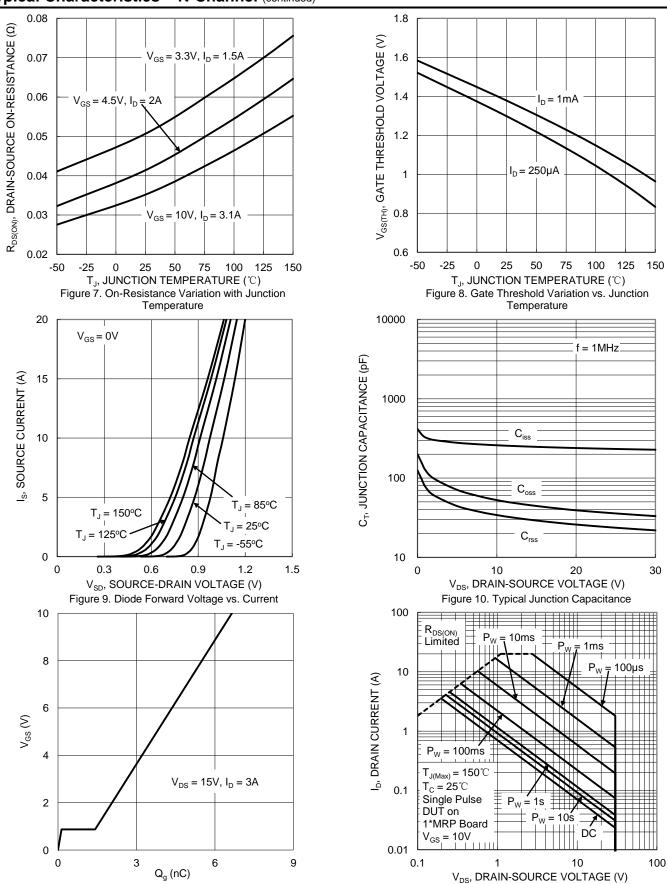
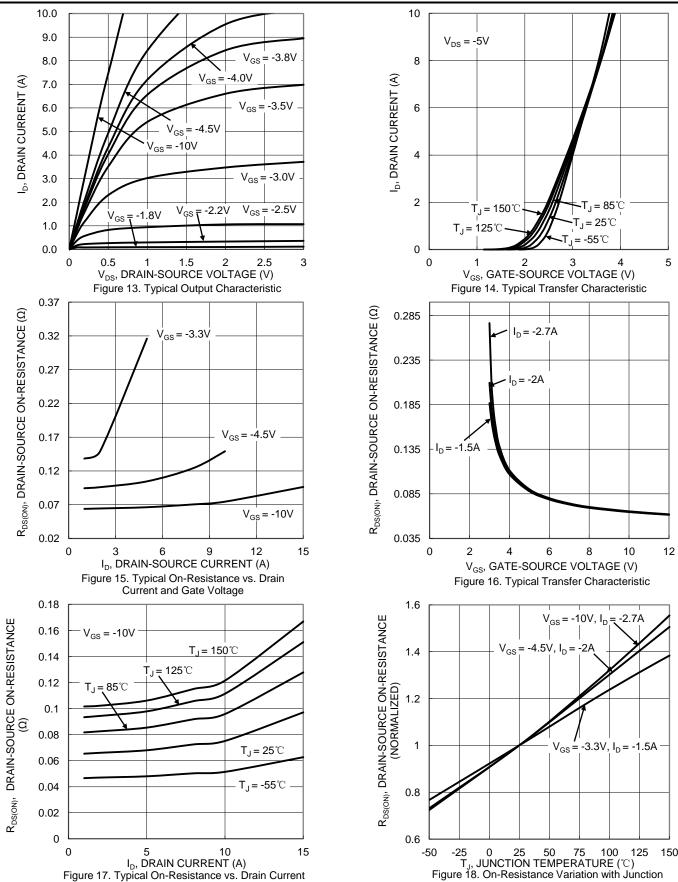


Figure 11. Gate Charge

Figure 12. SOA, Safe Operation Area



Typical Characteristics - P-Channel



Temperature

and Junction Temperature

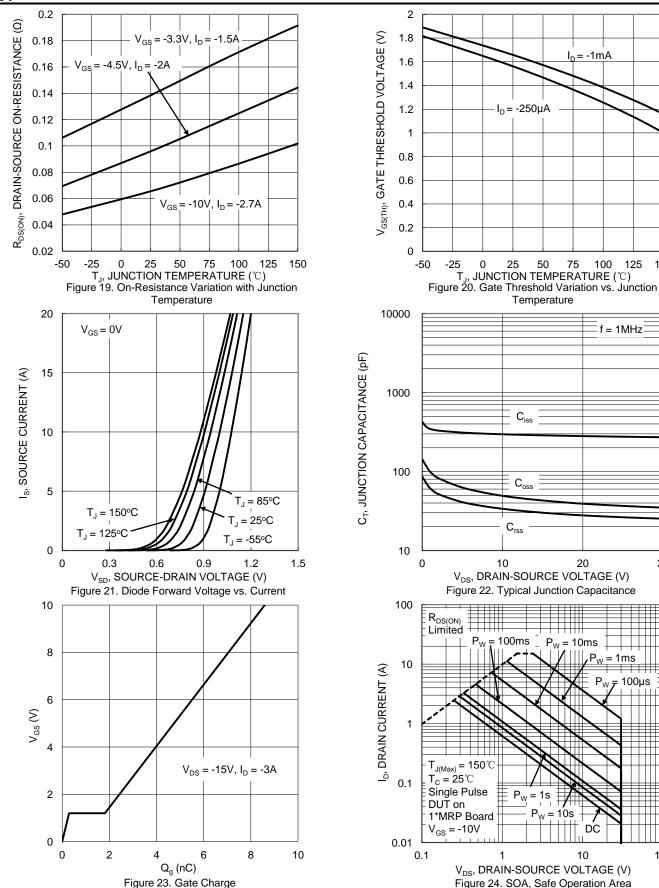
150

30

= 1ms



Typical Characteristics - P-Channel (continued)



100



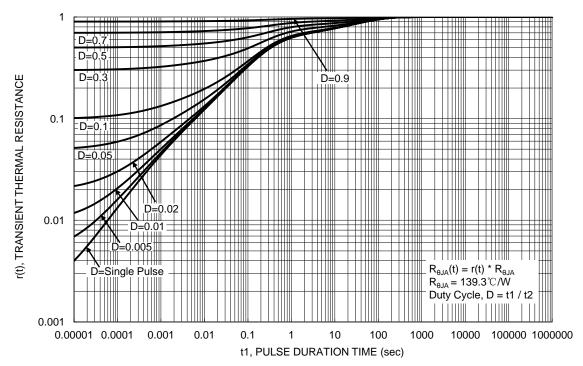


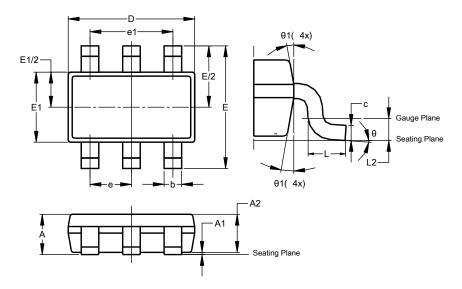
Figure 25. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

TSOT26

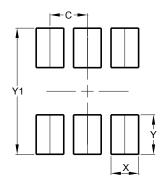


	TSOT26							
Dim	Min	Max	Тур					
Α	-	1.00	1					
A1	0.010	0.100	-					
A2	0.840	0.900	-					
D	2.800	3.000	2.900					
Е	2.800 BSC							
E1	1.500	1.700	1.600					
b	0.300	0.450	1					
С	0.120	0.200	_					
е	C	.950 BS	C					
e1	1	.900 BS	Ö					
L	0.30	0.50	1					
L2	C	.250 BS	S					
θ	0°	8°	4°					
θ1	4°	12°	-					
Δ	II Dimen	sions in	mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

TSOT26



Dimensions	Value (in mm)
С	0.950
Х	0.700
Υ	1.000
Y1	3.199



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